

Search Notes

Application/Control No.

10/769,907

Examiner

Binh X. Tran

Applicant(s)/Patent under
Reexamination

YAMAZAKI ET AL.

Art Unit

1792

SEARCHED

Class	Subclass	Date	Examiner
427	248.1	9/8/2008	BT
427	249.14	9/8/2008	BT
427	255.15	9/8/2008	BT
427	255.6	9/8/2008	BT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search keywords in inventor's name using databases in EAST	9/8/2008	BT